

N

## NDH8520C

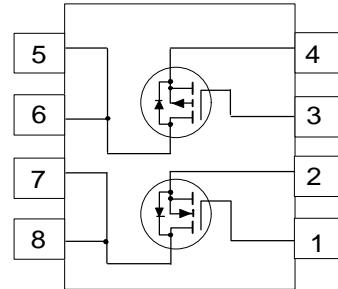
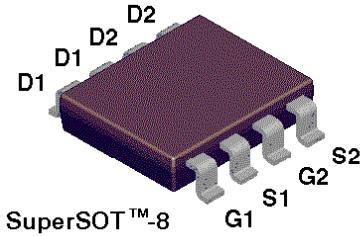
### Dual N & P-Channel Enhancement Mode Field Effect Transistor

#### General Description

These dual N- and P-Channel enhancement mode power field effect transistors are produced using National's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance and provide superior switching performance. These devices are particularly suited for low voltage applications such as notebook computer power management and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

#### Features

- N-Channel 2.8 A, 30 V,  $R_{DS(ON)}=0.07\Omega$  @  $V_{GS}=10$  V  
 $R_{DS(ON)}=0.1\Omega$  @  $V_{GS}=-4.5$  V
- P-Channel -2.2 A, -30 V,  $R_{DS(ON)}=0.11\Omega$  @  $V_{GS}=-10$  V  
 $R_{DS(ON)}=0.18\Omega$  @  $V_{GS}=-4.5$  V.
- High density cell design for extremely low  $R_{DS(ON)}$ .
- High power and current handling capability in a widely used surface mount package.
- Dual (N & P-Channel) MOSFET in surface mount package.



#### Absolute Maximum Ratings

$T_A = 25^\circ C$  unless otherwise noted

Symbol	Parameter	N-Channel	P-Channel	Units
$V_{DSS}$	Drain-Source Voltage	30	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V
$I_D$	Drain Current - Continuous - Pulsed	2.8	-2.2	A
		10	-10	
$P_D$	Power Dissipation for Single Operation	(Note 1)	0.8	W
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to 150	°C

#### THERMAL CHARACTERISTICS

$R_{TJA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	156	°C/W
$R_{TJC}$	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W

## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
<b>OFF CHARACTERISTICS</b>							
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	30			V
		$V_{\text{GS}} = 0 \text{ V}, I_D = -250 \mu\text{A}$	P-Ch	-30			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ $T_J = 55^\circ\text{C}$	N-Ch			1	$\mu\text{A}$
		$V_{\text{DS}} = -24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ $T_J = 55^\circ\text{C}$	P-Ch			10	$\mu\text{A}$
		$V_{\text{DS}} = 24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ $T_J = 55^\circ\text{C}$	P-Ch			-1	$\mu\text{A}$
		$V_{\text{DS}} = -24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ $T_J = 55^\circ\text{C}$	P-Ch			-10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate - Body Leakage, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	All			100	nA
$I_{\text{GSSR}}$	Gate - Body Leakage, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	All			-100	nA
<b>ON CHARACTERISTICS (Note 2)</b>							
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$ $T_J = 125^\circ\text{C}$	N-Ch	1	1.6	2.8	V
				0.8	1.2	2	
		$V_{\text{DS}} = V_{\text{GS}}, I_D = -250 \mu\text{A}$ $T_J = 125^\circ\text{C}$	P-Ch	-1	-1.5	-3	
				-0.8	-1.2	-2.2	
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 2.8 \text{ A}$ $T_J = 125^\circ\text{C}$	N-Ch		0.05	0.07	$\Omega$
					0.07	0.125	
		$V_{\text{GS}} = 4.5 \text{ V}, I_D = 2.3 \text{ A}$			0.077	0.1	
		$V_{\text{GS}} = -10 \text{ V}, I_D = -2.2 \text{ A}$ $T_J = 125^\circ\text{C}$	P-Ch		0.1	0.11	
$I_{\text{D(on)}}$	On-State Drain Current	$V_{\text{GS}} = -4.5 \text{ V}, I_D = -1.7 \text{ A}$			0.14	0.2	A
					0.17	0.18	
		$V_{\text{GS}} = 10 \text{ V}, V_{\text{DS}} = 5 \text{ V}$	N-Ch	10			
		$V_{\text{GS}} = 4.5 \text{ V}, V_{\text{DS}} = 5 \text{ V}$		3			
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{GS}} = -10 \text{ V}, V_{\text{DS}} = -5 \text{ V}$	P-Ch	-10			S
				-4			
		$V_{\text{DS}} = 10 \text{ V}, I_D = 2.8 \text{ A}$	N-Ch		5.8		
		$V_{\text{DS}} = -10 \text{ V}, I_D = -2.2 \text{ A}$	P-Ch		3.8		
<b>DYNAMIC CHARACTERISTICS</b>							
$C_{\text{iss}}$	Input Capacitance	$\text{N-Channel}$ $V_{\text{DS}} = 15 \text{ V}, V_{\text{GS}} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$	N-Ch		270		pF
			P-Ch		340		
$C_{\text{oss}}$	Output Capacitance	$\text{P-Channel}$ $V_{\text{DS}} = -15 \text{ V}, V_{\text{GS}} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$	N-Ch		170		pF
			P-Ch		218		
$C_{\text{trs}}$	Reverse Transfer Capacitance		N-Ch		55		pF
			P-Ch		100		

## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
SWITCHING CHARACTERISTICS (Note 2)							
$t_{D(on)}$	Turn - On Delay Time	N-Channel $V_{DD} = 10\text{ V}$ , $I_D = 1\text{ A}$ , $V_{GEN} = 10\text{ V}$ , $R_{GEN} = 6\Omega$	N-Ch		8	15	ns
			P-Ch		8	15	
$t_r$	Turn - On Rise Time	P-Channel $V_{DD} = -10\text{ V}$ , $I_D = -1\text{ A}$ , $V_{GEN} = -10\text{ V}$ , $R_{GEN} = 6\Omega$	N-Ch		15	28	ns
			P-Ch		18	35	
$t_{D(off)}$	Turn - Off Delay Time		N-Ch		15	28	ns
			P-Ch		28	50	
$t_f$	Turn - Off Fall Time		N-Ch		5	10	ns
			P-Ch		20	35	
$Q_g$	Total Gate Charge	N-Channel $V_{DS} = 15\text{ V}$ , $I_D = 2.8\text{ A}$ , $V_{GS} = 10\text{ V}$	N-Ch		9.4	17	nC
			P-Ch		10.9	14.5	
$Q_{gs}$	Gate-Source Charge	P-Channel $V_{DS} = -15\text{ V}$ , $I_D = -2.2\text{ A}$ , $V_{GS} = -10\text{ V}$	N-Ch		0.8		nC
			P-Ch		1.4		
$Q_{gd}$	Gate-Drain Charge		N-Ch		3		nC
			P-Ch		3.6		

## DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

$I_s$	Maximum Continuous Drain-Source Diode Forward Current		N-Ch			0.67	A
			P-Ch			-0.67	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}$ , $I_s = 0.67\text{ A}$ (Note2)	N-Ch		0.7	1.2	V
		$V_{GS} = 0\text{ V}$ , $I_s = -0.67\text{ A}$ (Note2)	P-Ch		-0.76	-1.2	

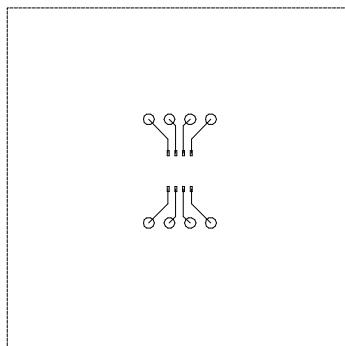
### Notes:

- $R_{JJA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{JJC}$  is guaranteed by design while  $R_{JCA}$  is determined by the user's board design.

$$P_D(t) = \frac{T_J - T_A}{R_{JJA}(t)} = \frac{T_J - T_A}{R_{JJC} + R_{JCA}(t)} = I_D^2(t) \times R_{DS(ON)}@T_J$$

Typical  $R_{JJA}$  for single device operation using the board layout shown below on 4.5"x5" FR-4 PCB in a still air environment:

156°C/W when mounted on a 0.0025 in<sup>2</sup> pad of 2oz copper.



Scale 1 : 1 on letter size paper.

- Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2.0\%$ .

## Typical Electrical Characteristics: N-Channel

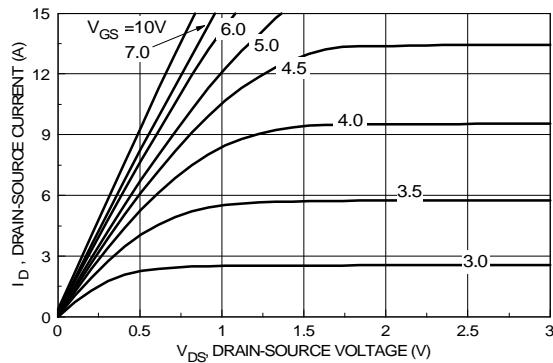


Figure 1. N-Channel On-Region Characteristics.

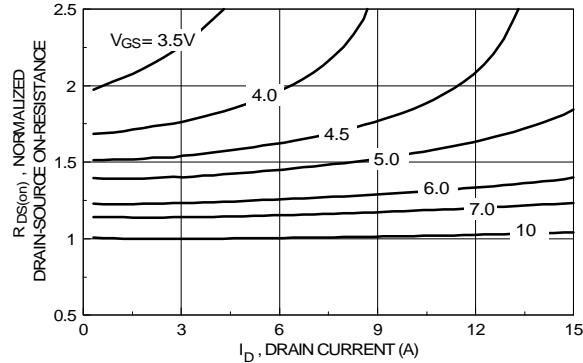


Figure 2. N-Channel On-Resistance Variation with Gate Voltage and Drain Current.

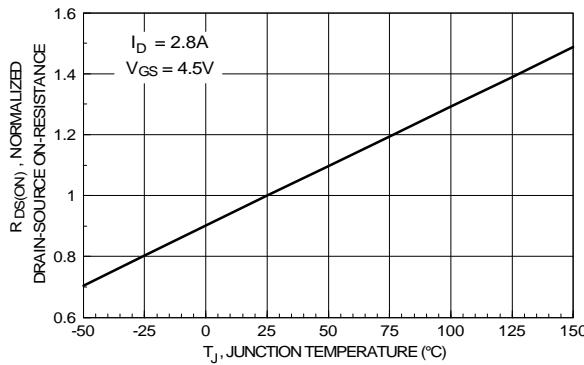


Figure 3. N-Channel On-Resistance Variation with Temperature.

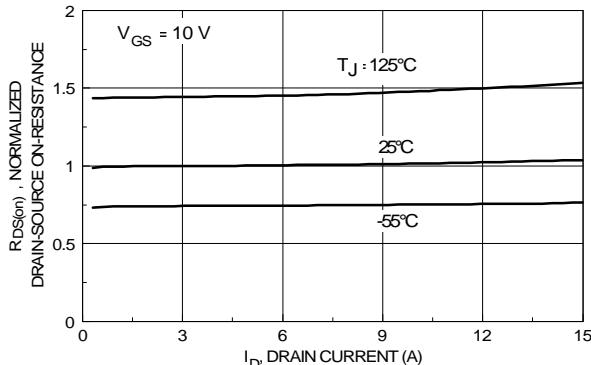


Figure 4. N-Channel On-Resistance Variation with Drain Current and Temperature.

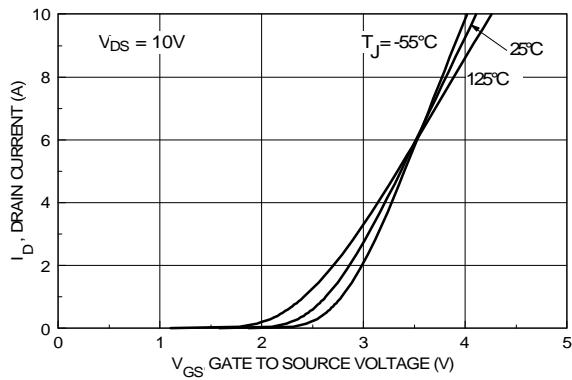


Figure 5. N-Channel Transfer Characteristics.

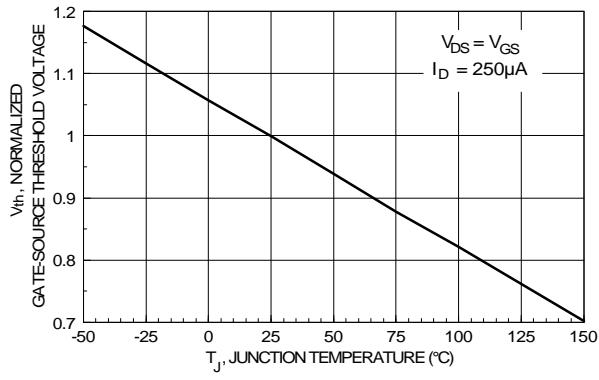


Figure 6. N-Channel Gate Threshold Variation with Temperature.

## Typical Electrical Characteristics: N-Channel (continued)

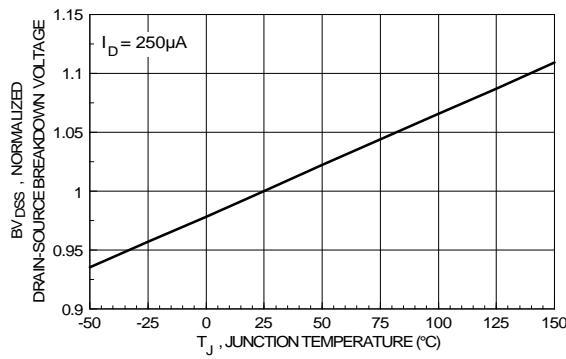


Figure 7. N-Channel Breakdown Voltage Variation with Temperature.

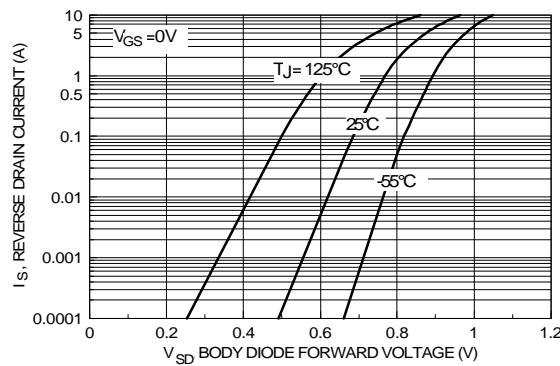


Figure 8. N-Channel Body Diode Forward Voltage Variation with Current and Temperature.

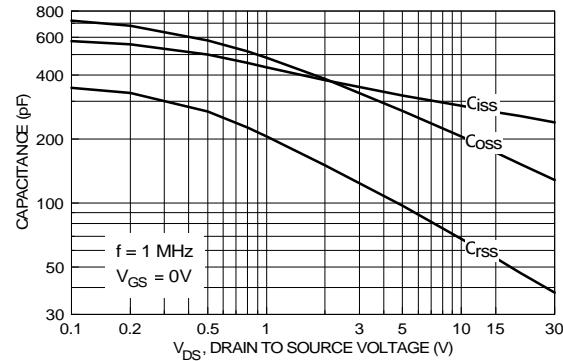


Figure 9. N-Channel Capacitance Characteristics.

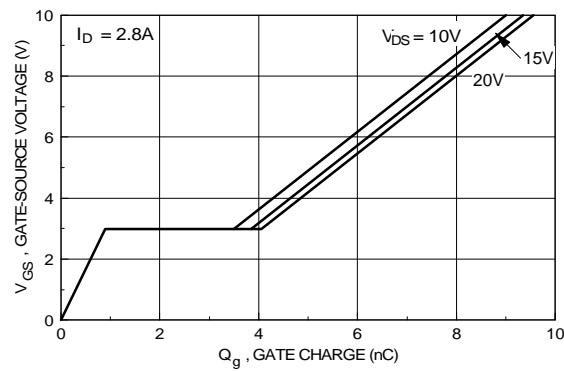


Figure 10. N-Channel Gate Charge Characteristics.

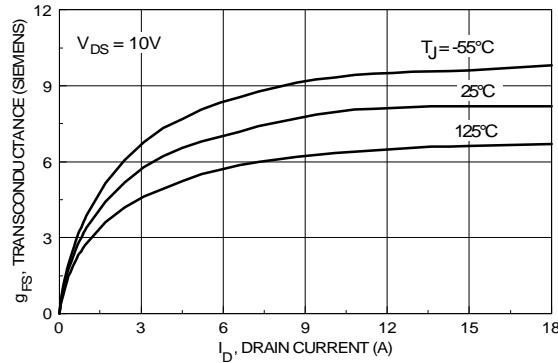


Figure 11. N-Channel Transconductance Variation with Drain Current and Temperature.

## Typical Electrical Characteristics: P-Channel (continued)

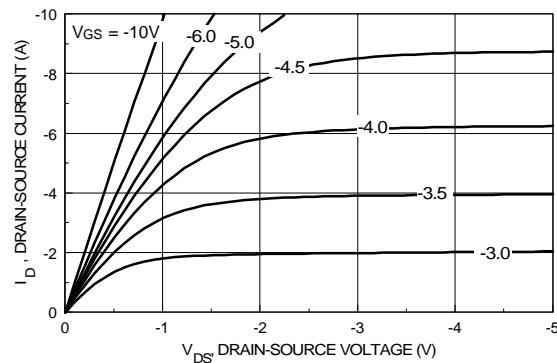


Figure 12. P-Channel On-Region Characteristics.

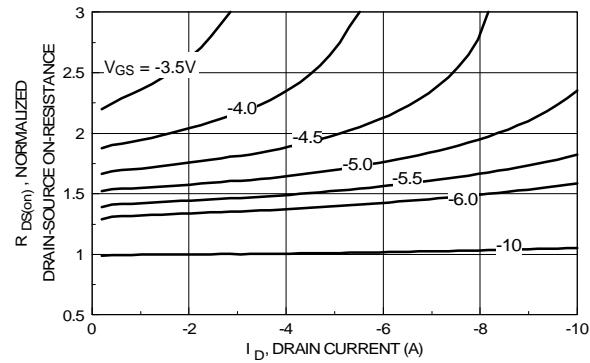


Figure 13. P-Channel On-Resistance Variation with Gate Voltage and Drain Current.

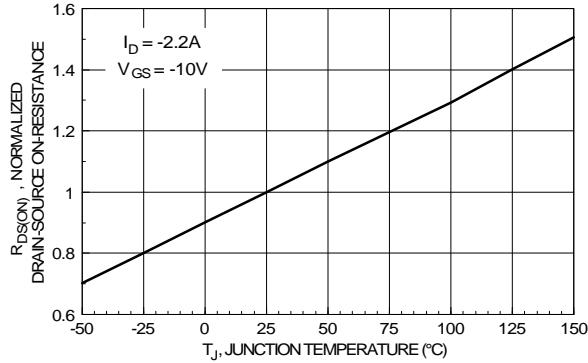


Figure 14. P-Channel On-Resistance Variation with Temperature.

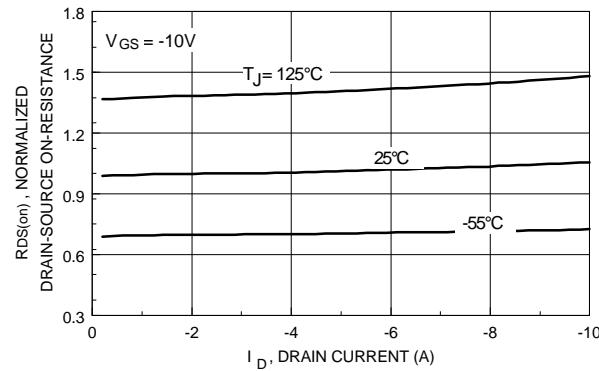


Figure 15. P-Channel On-Resistance Variation with Drain Current and Temperature.

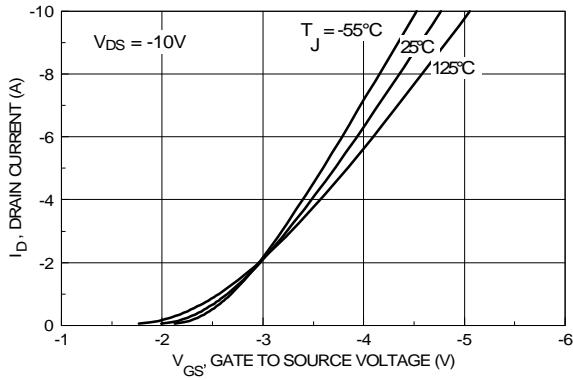


Figure 16. P-Channel Transfer Characteristics.

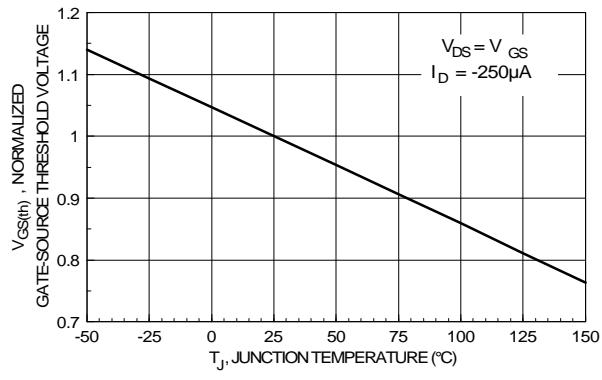


Figure 17. P-Channel Gate Threshold Variation with Temperature.

## Typical Electrical Characteristics: P-Channel (continued)

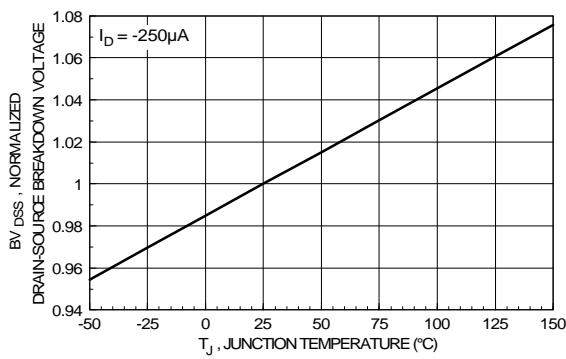


Figure 18. P-Channel Breakdown Voltage Variation with Temperature.

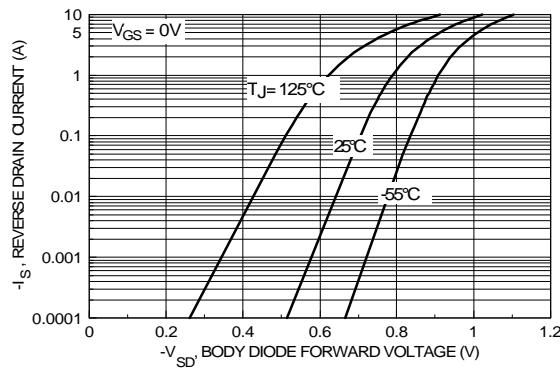


Figure 19. P-Channel Body Diode Forward Voltage Variation with Current and Temperature.

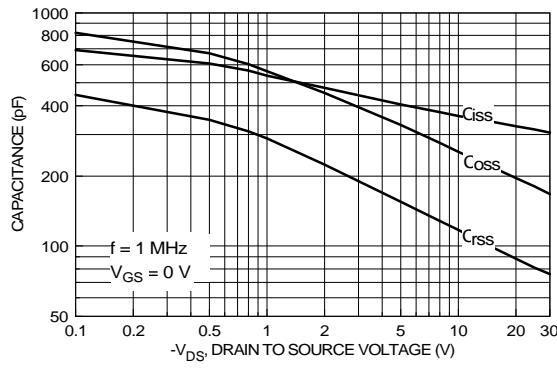


Figure 20. P-Channel Capacitance Characteristics.

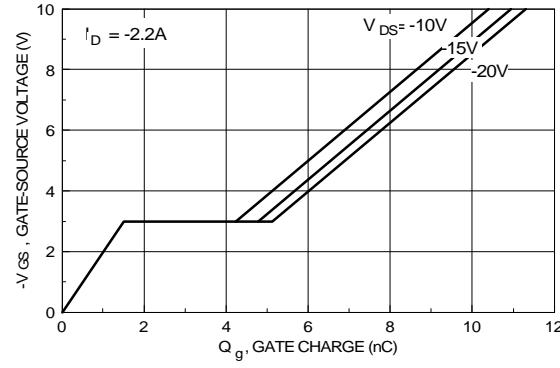


Figure 21. P-Channel Gate Charge Characteristics.

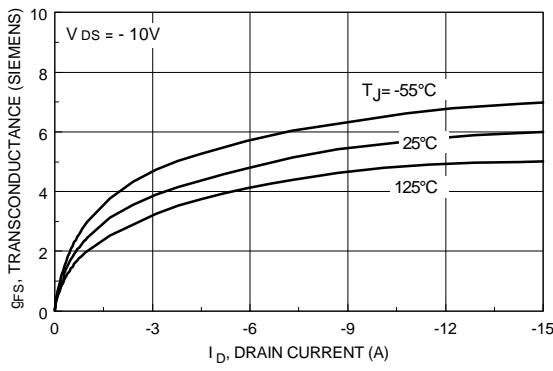


Figure 22. P-Channel Transconductance Variation with Drain Current and Temperature.

## Typical Thermal Characteristics: N & P-Channel

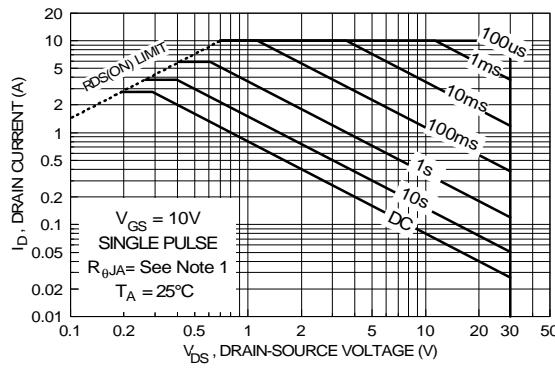


Figure 23. N-Channel Maximum Safe Operating Area.

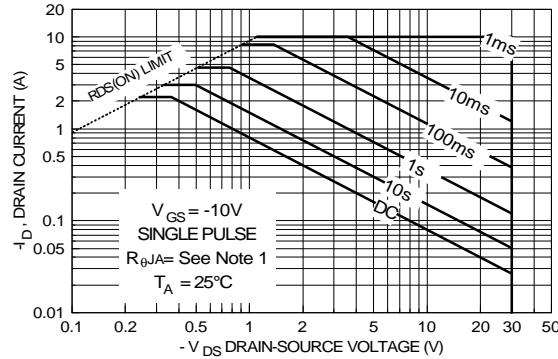


Figure 24. P-Channel Maximum Safe Operating Area.

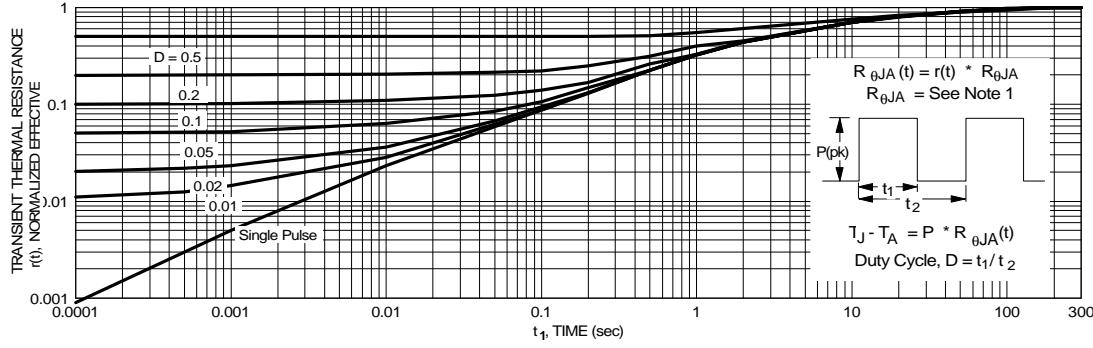


Figure 25. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note1. Transient thermal response will change depending on the circuit board design.

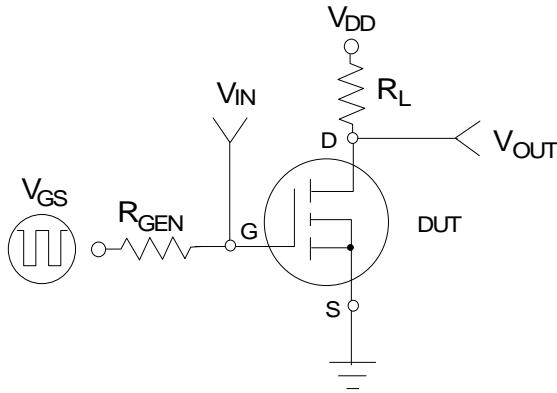


Figure 26. N or P-Channel Switching Test Circuit.

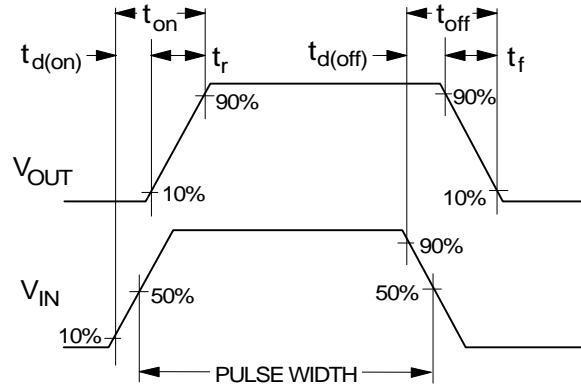


Figure 27. N or P-Channel Switching Waveforms.